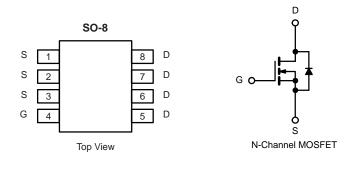


# N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
100	0.040 at V <sub>GS</sub> = 10 V	6.4	23 nC			
100	0.047 at V <sub>GS</sub> = 8 V	5.5	23110			



## **FEATURES**

- Halogen-free According to IEC 61249-2-21
   Definition
- Extremely Low Q<sub>gd</sub> for Switching Losses
- 100 % Rg Tested
- 100 % Avalanche Tested
- Compliant to RoHS Directive 2002/95/EC

## **APPLICATIONS**

• Primary Side Switch



Available

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_A = 25 \text{ °C}$ , unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	100	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	I <sub>D</sub>	6.4 5.1 5.5 <sup>b, c</sup> 4.5 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	26	A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.5 2.6 <sup>b, c</sup>		
Single Pulse Avalanche Current	e Pulse Avalanche Current L = 0.1 mH		20		
Single Pulse Avalanche Energy		E <sub>AS</sub>	20	mJ	
Maximum Power Dissipation	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	PD	5.9 3.8 3.1 <sup>b, c</sup> 2 <sup>b, c</sup>	W	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	C	

THERMAL RESISTANCE RATINGS						
	Symbol	Typical	Maximum	Unit		
t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W		
Steady State	R <sub>thJF</sub>	17	21			
	t ≤ 10 s	$\begin{array}{c c} \textbf{Symbol} \\ \hline t \leq 10 \text{ s} & \textbf{R}_{thJA} \end{array}$	Symbol         Typical           t ≤ 10 s         R <sub>thJA</sub> 33	Symbol         Typical         Maximum           t ≤ 10 s         R <sub>thJA</sub> 33         40		

Notes:

a. Based on T<sub>C</sub> = 25 °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 80 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	· ·						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	100			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L _ 250 uA		172		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 10		mv/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1.0		3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zara Cata Valtaga Drain Current		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current	DSS	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	30			A	
Drain-Source On-State Resistance <sup>a</sup>	P	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A		0.036	0.040	Ω	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 8 V, I <sub>D</sub> = 5 A		0.037	0.047		
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 5 A		23		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1735		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 50 V, $V_{GS}$ = 0 V, f = 1 MHz		160			
Reverse Transfer Capacitance	C <sub>rss</sub>			37			
Total Gate Charge	Qg	$V_{DS} = 75$ V, $V_{GS} = 10$ V, $I_{D} = 5$ A		28.5	43	43	
				23	35	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 75 V, $V_{GS}$ = 8 V, $I_{D}$ = 5 A		8			
Gate-Drain Charge	Q <sub>gd</sub>			6.5			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		0.85	1.3	Ω	
Turn-on Delay Time	t <sub>d(on)</sub>			14	21		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 10 $\Omega$		12	18		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong \text{5}$ A, $\text{V}_\text{GEN}$ = 10 V, $\text{R}_\text{g}$ = 1 $\Omega$		22	33		
Fall Time	t <sub>f</sub>			6	10	<b>n</b> 0	
Turn-On Delay Time	t <sub>d(on)</sub>			16	24	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 10 $\Omega$		12	18	]	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		20	30		
Fall Time	t <sub>f</sub>			7	12	]	
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			7.7	۸	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				50	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 2.6 A		0.77	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-		63	95	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 5 A dt/dt = 100 A/tro T = 25 °C		110	165	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		49			
Reverse Recovery Rise Time	t <sub>b</sub>			14		ns	

Notes:

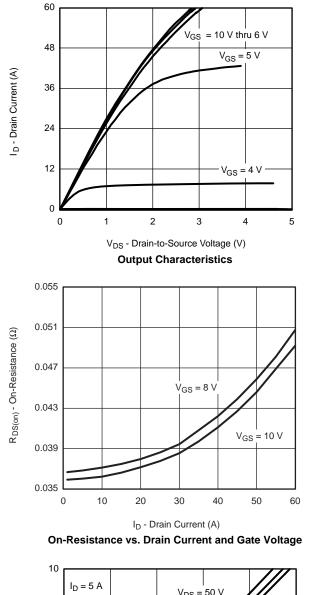
a. Pulse test; pulse width  $\leq 300~\mu\text{s},$  duty cycle  $\leq 2~\%$ 

a. Guaranteed by design, not subject to production testing.

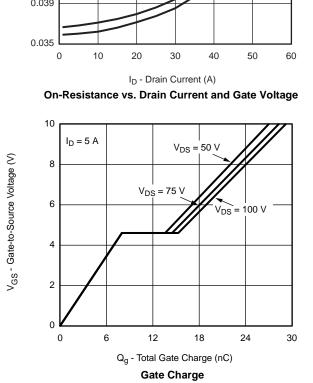
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

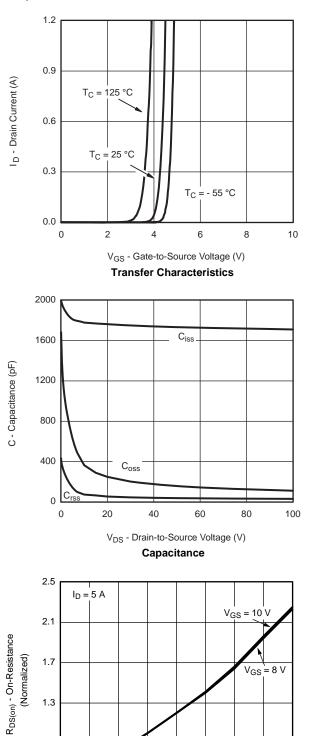
emi





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





1.3

0.9

0.5

- 50

- 25

0

25

50

T<sub>J</sub> - Junction Temperature (°C)

**On-Resistance vs. Junction Temperature** 

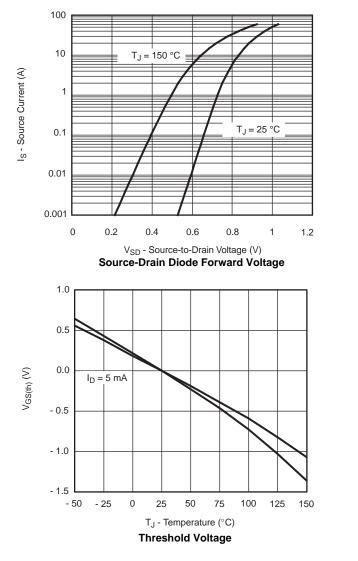
75

100

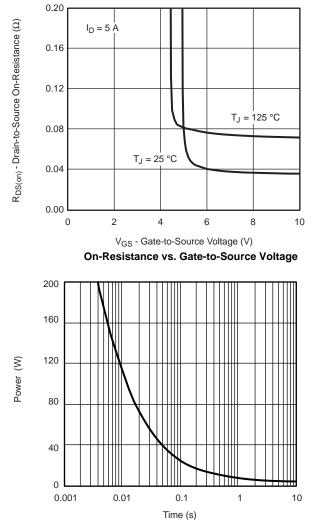
125

150

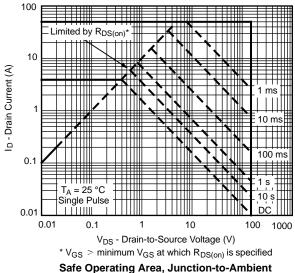




## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

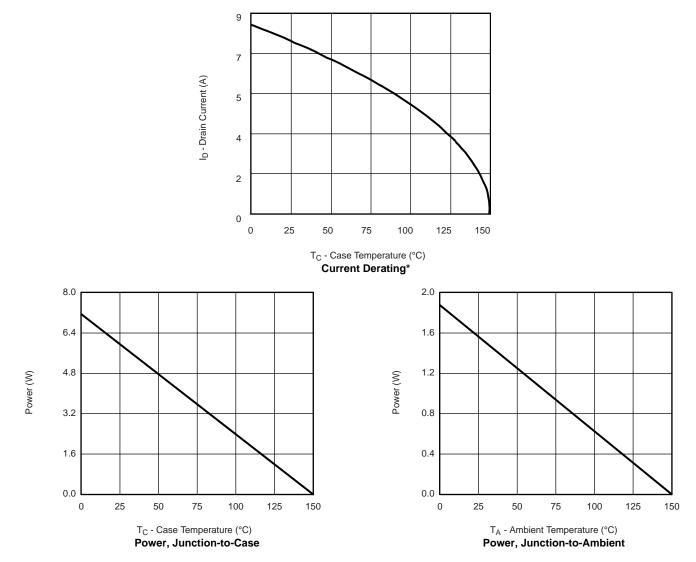


Single Pulse Power, Junction-to-Ambient



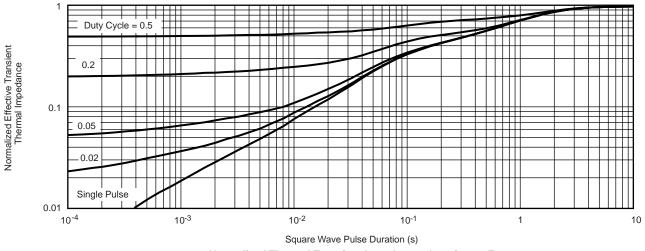


## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

### 1 Duty Cycle = 0.5 Normalized Effective Transient Thermal Impedance 0.2 Notes 0.1 4 0.1 P<sub>DM</sub> 0.05 t<sub>1</sub> t2 t<sub>1</sub> 1. Duty Cycle, D = t<sub>2</sub> 0.02 2. Per Unit Base = RthJA = 65 °C/W 3. $T_{JM} - T_A = P_{DM}Z_{thJA}^{(t)}$ Single Pulse 4. Surface Mounted 1 1 1 1 1 1 1 1 0.01 10<sup>-2</sup> 10-4 10<sup>-3</sup> 10<sup>-1</sup> 1000 10 100 1 Square Wave Pulse Duration (s) Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

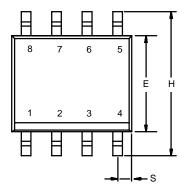
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## SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

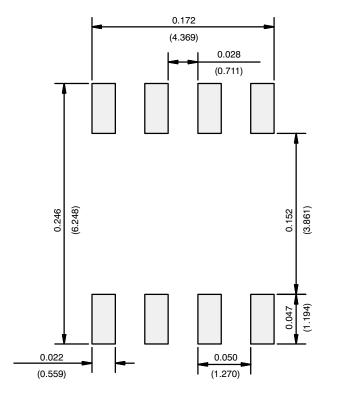




	MILLIMETERS		INC	HES	
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A <sub>1</sub>	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



## **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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